Oxadiazole Based Polyether as Sensitive Films for Ratiometric Optical Temperature Detection

H. C. Neitzert, S. Cuccurullo, S. Concilio, and P. Iannelli

1 Dipartimento di Ingegneria Industriale (DIIn), Salerno University, Via Giovanni Paolo II 132, 84084 Fisciano, Italy
2 Dipartimento di Farmacia (DIFARMA), Salerno University, Via Giovanni Paolo II 132, 84084 Fisciano, Italy

Correspondence should be addressed to H. C. Neitzert; neitzert@unisa.it

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A new type of polymer, based on the oxadiazole group, has been tested as indicator material for a ratiometric photoluminescence and optical reflection based temperature sensor in the temperature range between 30°C and 60°C. Thin films of the new polymer have been deposited by spin-coating on a glass substrate, excited by means of a low-cost near UV-LED. The optical spectrum, as detected by a fiber-based PC-card optical spectrometer, consisted of the reflection peak at the excitation wavelength and two distinct photoluminescence peaks at 430 nm and 480 nm, both in the blue spectral region. The peak amplitudes of all three spectral peaks depend linearly on the exciting light intensity. Changing the sample temperature, all peak amplitude values decrease monotonously with increasing temperature. By using a ratiometric approach, it has been found that the ratio between the two photoluminescence peaks was almost constant with temperature, while the ratio between the main photoluminescence peak at 430 nm and the reflection peak around 380 nm scaled nicely with the ambient temperature. Therefore, it has been proposed to use the latter criterion and a simple polynomial fit to the temperature versus peak amplitude relation.

1. Introduction

Temperature sensing is one of the most classical sensor domains. Despite the availability of excellent integrated silicon solutions with good linearity and sensitivity over a large temperature range there is even in this field a lot of research going on [1–3]. For example, the compensation of mechanical stress in silicon bandgap reference sensors has been shown to improve the performance of these types of sensors [4]. Nevertheless, there is a continuing interest in novel solutions for temperature sensors due to particular measurement conditions. For harsh environments as in space, for example, Ruthenium based thin film resistors have been shown to withstand rather high irradiation doses [5]. As another example in semiconductor growth environments, the substrates that are used for deposition can often not be in intimate contact with conventional sensors. On the other hand, the substrate temperature is often the most important parameter for semiconductor film growth [6] and the quality of interfaces in heterojunctions with extreme interest, for example, for high efficiency silicon based [7] or polymer type solar cells [8]. Therefore, a variety of noncontact temperature sensor solutions have been developed, based, for example, on emission corrected pyranometry [9] or diffuse reflectance spectroscopy [10]. Optical measurements give additionally the possibility to follow on a very short time scale the temperature evolution in materials and devices. For example, during the application of short ESD pulses to semiconductor lasers, the immediate temperature rise results in fast suppression of the optical emission of vertical cavity surface emitting lasers (VCSELs) [11] and can after opportune calibration be used to monitor the fast temperature transient during ESD pulse application. Optical temperature sensors, based on band-edge shifts, enable also the easy realization of optical fiber-based solutions that permit measuring the temperature in remote location [12].

Another important research field, where conventional sensors are difficult to use, is biology. Therefore, in biological environments, optical temperature sensing techniques are strongly favored. In this case, only a limited temperature range is of interest, but stability in an aggressive environment and biocompatibility are required. Sensitive in vitro and
in vivo measurements have, for example, been achieved by using a dual emissive phosphorescent polymeric thermometer that incorporates two long-lived phosphorescent iridium complexes into an acrylamide-based thermosensitive polymer [13]. In this case, even intracellular temperature measurements have been reported. In addition, fluorescence spectroscopy, using a green fluorescent protein as thermal nanoprobe, has been shown to enable intracellular noninvasive temperature monitoring [14]. While often nonbiological materials are used as markers in biological applications, recently it has also been shown that biological cells from Candida can be used together with multiwalled carbon nanotubes to form a stable tissue that has excellent temperature sensing properties in a wide temperature range up to 373 K as a simple resistance thermometer [15].

Here we want to show the possibility to use a new type of polymer [16], based on the oxadiazole group for the realization of a photoluminescence (PL) based temperature sensor, and discuss the most stable readout configuration. In literature [13] it is, for example, reported that, for some materials with multiple peak emission, the ratio between different emission peak amplitudes is a good measure for the sample temperature. This is checked in the case of the proposed oxadiazole based polymer and compared to different ratiometric criteria.

2. Sample Structure and Preparation

The synthesis and the structural characterization of the segmented polyesters (PO), containing the oxadiazole unit, have been reported elsewhere [16]. The general structure of the synthesized polymer is shown in Scheme 1. The insertion of the flexible aliphatic segments along and aside the chain reduces the melting temperature and improves the solubility in organic solvents, while promoting the appearing of the nematic phase. In our specific case the copolymer with \( m = 8 \) and \( a = 0.5 \) has been used. An inherent viscosity value of 0.39 dL/g at 25°C has been measured for this copolymer, using an Ubbelohde viscometer. The viscosity measurements were performed in 0.5 g/dL chloroform + 5% trifluoroacetic acid solutions. The good solubility in chlorinate solvents allows the preparation of films with homogeneous thickness by spinning technique and the glass transition temperature in the range 100–120°C ensures good stability of the film morphology at room temperature and above. All these features make PO suitable as active material in the fabrication of electronic devices, such as polymer LEDs [17] and low-voltage electronic memories [18]. Oxadiazole embedded in polyurethane [19] or in combination with polyazothines [20] has also been reported to be applicable as electrical switching device.

It should be mentioned that already early reports on oxadiazole based polymers as electroluminescent devices [21, 22] report strong emission in the blue wavelength range and also a relatively stable behavior even under normal ambient conditions [23, 24]. Another particular interesting feature of these polymers is the low overlap of emission and absorption spectra, so that the reabsorption is minimized [24], which results in a high overall efficiency, when using this type of polymer as active layer in LEDs [25].

It should also be mentioned that oxadiazole groups with their excellent electron conducting properties are not only used in polymerized form. Also small molecules based blue emitting organic LEDs and heterojunction diodes with oxadiazole units in combination with carbazole units have been reported [26, 27].

The investigated samples were then realized by the deposition by spin-coating on top of a glass substrate. The thickness of the polymer film, obtained with the used spinning conditions, was about 90 nm with a surface roughness of about 4 nm. The film thickness has been determined by atomic force microscope (AFM) imaging of the films, deposited on the glass substrate and cut with a razor blade.

3. Measurement Setup

The setup for temperature dependent photoluminescence measurements is schematically shown in Figure 1. A near UV-LED with integrated glass lens (nominal wavelength of 370 nm and a maximal optical power of 1 mW) and a fiber coupled PC-based Ocean Optics “PC2000” spectrometer for the detection have been used. The optical geometry is optimized in a way that the exciting LED is mounted perpendicular to the investigated film, while the receiving optical fiber is positioned with a 45° angle respective to the film surface. With this geometry it could be achieved that the signal height of the exciting UV light and the photoluminescence signal height are in the same order of magnitude for polymer films of about 90 nm thickness.

The temperature control has been realized with Peltier elements inserted between the dissipator and a thinner aluminum plate, which has been equipped with a calibrated NTC resistor as temperature sensor. The glass plate with the PO film has been tightly attached to the upper aluminum plate and thermally conducting paste has been used to achieve a good thermal contact between glass substrate and aluminum plate. The temperature control has been done using the PID
Figure 1: Temperature control system and optical measurement setup.

4. Results and Discussions

4.1. Optical Characterization. In Figure 2, typical photoluminescence spectra for spin-coating deposited polymer films with a UV-LED (nominally emitting at 370 nm and with an optical output power of 1 mW) measured at 4 different temperatures between 30°C and 60°C are shown.

No optical filter has been used to suppress the UV light used for excitation so that in the optical spectra below 400 nm also a contribution of the UV light, reflected by the sample, is observed. The peak position of the reflected light has been found to be at 380 nm, slightly higher than the nominal wavelength of the commercial LED. Besides the dominant luminescence peak at 430 nm, a broad shoulder at a wavelength of 480 nm with a smaller peak amplitude can be seen. It should be mentioned that we found that the shape of the photoluminescence spectrum in a wide range does not depend on the exciting optical power value.

From the spectra, partially shown in Figure 2, we extracted the peak amplitudes for the PL emission peaks and additionally for the peak, related to the reflection of the exciting light. The temperature dependence of these amplitude values in a range between 30°C and 60°C is shown in Figure 3(a). A monotonic decrease of the amplitudes of all three optically revealed peaks with increasing temperature is found. For the PL peaks at 430 nm (first peak) and 480 nm (second peak) a smooth behavior has been found, while in the case of the reflection peak at 380 nm also a monotonic decrease but with ondulations and local maxima at 40°C and 55°C has been observed. This latter observation may be due to interference effects in the thin organic layer.

We checked also how the revealed optical peak amplitudes depend on the exciting light power. As can be seen in Figure 3(b), increasing the luminescence peak amplitude values (at 430 nm and 480 nm) and also the UV reflectance peak amplitude value is strictly linear with increasing power of the UV-LED in the investigated power range up to 1 mW. In a next step we plotted the ratio of the 430 nm PL emission peak and the 480 nm PL emission peak as a function of the sample temperature (see Figure 4). No clear correlation between PL emission amplitude ratio and sample temperature is found. Between 30°C and 45°C the ratio is almost independent of the sample temperature and has a value of about 1.8, while at higher temperatures a nonmonotonic behavior is found. These findings show that the ratio between two PL peaks as often proposed in literature [13] cannot in our case be used for a ratiometric measurement of the sample temperature.

As an alternative ratiometric measure, we plotted in Figure 5 the ratio between the reflection peak amplitude and the first PL emission peak amplitude as a function of the substrate temperature. In this case we find a monotonic increase of the peak amplitude ratio with increasing temperature from a value of about 0.85 at 30°C up to a value of about 1.5 at 60°C. The behavior can nicely be fitted (see fitting parameters in the inset) with a 2nd-order polynomial fit and the R coefficient is higher than 0.99, even if the abovementioned interference peaks at 40°C and 55°C are slightly visible also in this plot. Therefore it can be concluded that the peak amplitude of the PL emission itself is a good measure for the sample temperature (see Figure 2). By including the reflection peak amplitude, however, even a good ratiometric criterion for temperature measurements, using the oxadiazole based polyether, has been found.

4.2. Electrical Characterization. In order to determine the film conductivity, the current-voltage characteristics of a spin-coated film in a coplanar geometry with a gap of about 2 mm between the parallel contacts on the surface were measured. In Figure 6 we see the electrical current, measured during 3 thermal cycles between room temperature and 60°C with an applied voltage of 100 V, where the temperature
Figure 3: Dependence of the amplitudes of the reflection peak and of the 2 principal photoluminescence peaks (first peak at 430 nm and second peak at 480 nm), (a) on the sample temperature (with an excitation LED power of 1 mW) and (b) on the excitation LED power (at room temperature).

![Graphs showing the dependences of peak amplitudes on temperature and LED power.](image)

Figure 4: Ratio between the principal photoluminescence peaks with linear fit (the fitting parameters are shown as inset).

![Graph showing the ratio between peak amplitudes with linear fit.](image)

Figure 5: Ratio between the amplitude of the reflection peak and the amplitude of the principal photoluminescence peak at 430 nm as a function of the sample temperature with polynomial fit (red line) (the fit parameters are shown in the inset).

![Graph showing the ratio between reflection peak intensity and second PL peak intensity ratio.](image)

has been changed stepwise with steps of 5°C using the Peltier based temperature control system, which has been described above. The monitoring of the sample temperature with the NTC sensor (upper trace in Figure 6) shows the extremely good stability of the temperature control without any overshoot during the temperature changes. Regarding the development of the conductivity we observe directly after applying the constant voltage at 25°C a rather unstable current, which is strongly decreasing within the first minutes. Later on during the first cycle, the current remains relatively stable during the single temperature steps. This holds in
5. Conclusions

A simple but very stable measurement setup has been realized for the temperature dependent optical and electrical characterization of a new, oxadiazole containing, electron conducting polymer with relevant applications as polymer LED and a low-voltage electrical bistable device. With the low-cost optical measurement system, three principal peaks have been measured on the spin-coating deposited polymer film. The first one is related to the exciting light reflection and the other two peaks are correlated with the blue light photoluminescence at 430 nm and at 480 nm. It has been found that all three peak amplitudes decrease with
increasing sample temperature. As best ratiometric based criterion, the ratio between the reflection peak and the most prominent photoluminescence peak has been found. In this case, a simple polynomial temperature-peak ratio relation has been observed. Additional electrical conductivity measurements in coplanar configuration during multiple temperature cycling have been performed, revealing an unstable long-term behavior, developing after the first, relatively stable, temperature cycle.

**Disclosure**

Present address of S. Cuccurullo is STMicroelectronics SRL, Via Defeo Remo 1, 80022 Arzano, Italy.

**Competing Interests**

The authors declare that there is no conflict of interests regarding the publication of this paper.

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